Application/Control No.	Applicant(s)/Patent under Reexamination
09/896,255	HSU ET AL.
Examiner	Art Unit
Fllon C. Tran	2124

SEARCHED					
Class	Subclass	Date	Examiner		
713	189	6/20/2005	ECT		
713	192	6/20/2005	ECT		
713	167	6/20/2005	ECT		
713	200	6/20/2005	ECT		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	,				
			X		
7					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, INVENTOR	6/20/2005	ECT
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